Search Notes			

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/617,901	DUNKLE, MARK VANDEVERT	
Examiner	Art Unit	
Usmaan Saeed	2166	

SEARCHED			
Class	Subclass	Date	Examiner
707	102	1/5/2006	US
707	103R	1/5/2006	US
707	10	1/5/2006	US

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
			
	<u> </u>		
	:		

SEARCH NOT (INCLUDING SEARCH)
	DATE	EXMR
Inventor & related case search	1/9/2006	US
East (US-PGPUB, USPAT, USOCR, EPO, JPO, DERWENT, IBM_TDB)	1/9/2006	US
Consulted Primary Examiner (Leslie Wong)	1/10/2006	US
Plus	1/4/2006	us